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**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

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In re application of:

DAVID R. HEMBREE  
WARREN M. FARNWORTH  
SALMAN AKRAM  
ALAN G. WOOD  
C. PATRICK DOHERTY  
ANDREW J. KRIVY

Serial No.:

Art Unit:

Division of Serial No. 09/929,388  
filed August 14, 2001

Examiner

Filing Date: February 5, 2002

For: METHOD FOR TESTING  
SEMICONDUCTOR WAFERS (AS AMENDED)

Attorney Docket No. 96-750.3

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**PRELIMINARY AMENDMENT  
SUBMITTED WITH CONTINUING APPLICATION  
UNDER 37 CFR 1.53(b)**

**February 5, 2002**

Assistant Commissioner of Patents  
BOX PATENT APPLICATION  
Washington, D.C. 20231

Sir:

This Preliminary Amendment is being filed with a divisional application under 37 CFR 1.53(b). Please amend the captioned case as follows.

**In the Drawings**

Please substitute the attached new formal drawings for the drawings originally filed in parent application serial no. 08/797,719. The new formal drawings are also being submitted separately to the Official Draftsperson by "Transmittal Letter To The Official Draftsperson".